

74ABT125

Quad buffer; 3-state

Rev. 7 — 25 November 2015

Product data sheet

1. General description

The 74ABT125 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT125 device is a quad buffer that is ideal for driving bus lines. The device features four output enable inputs ($\overline{1OE}$, $\overline{2OE}$, $\overline{3OE}$, $\overline{4OE}$), each controlling one of the 3-state outputs.

2. Features and benefits

- Quad bus interface
- 3-state buffers
- Live insertion and extraction permitted
- Output capability: HIGH -32 mA; LOW $+64$ mA
- Power-up 3-state
- Inputs are disabled during 3-state mode
- Latch-up protection exceeds 500 mA per JESD78 class II level A
- ESD protection:
 - ◆ HBM JESD22-A114F exceeds 2000 V
 - ◆ MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from -40 °C to $+85$ °C

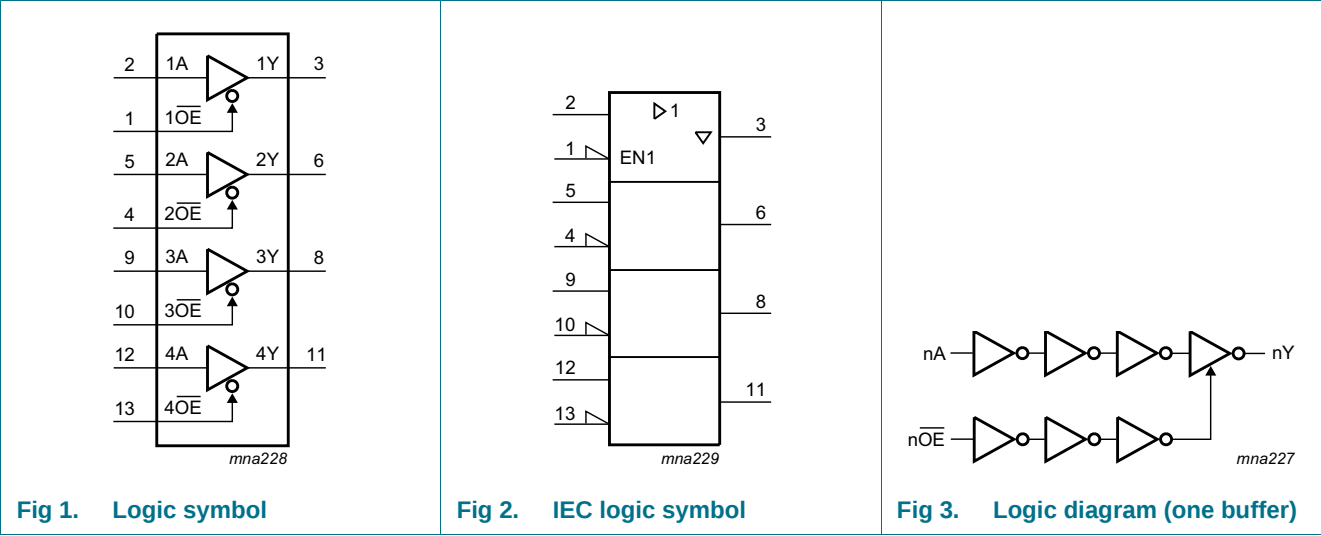
3. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
74ABT125D	-40 °C to $+85$ °C	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1
74ABT125DB	-40 °C to $+85$ °C	SSOP14	plastic shrink small outline package; 14 leads; body width 5.3 mm	SOT337-1
74ABT125PW	-40 °C to $+85$ °C	TSSOP14	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	SOT402-1
74ABT125BQ	-40 °C to $+85$ °C	DHVQFN14	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body $2.5 \times 3 \times 0.85$ mm	SOT762-1

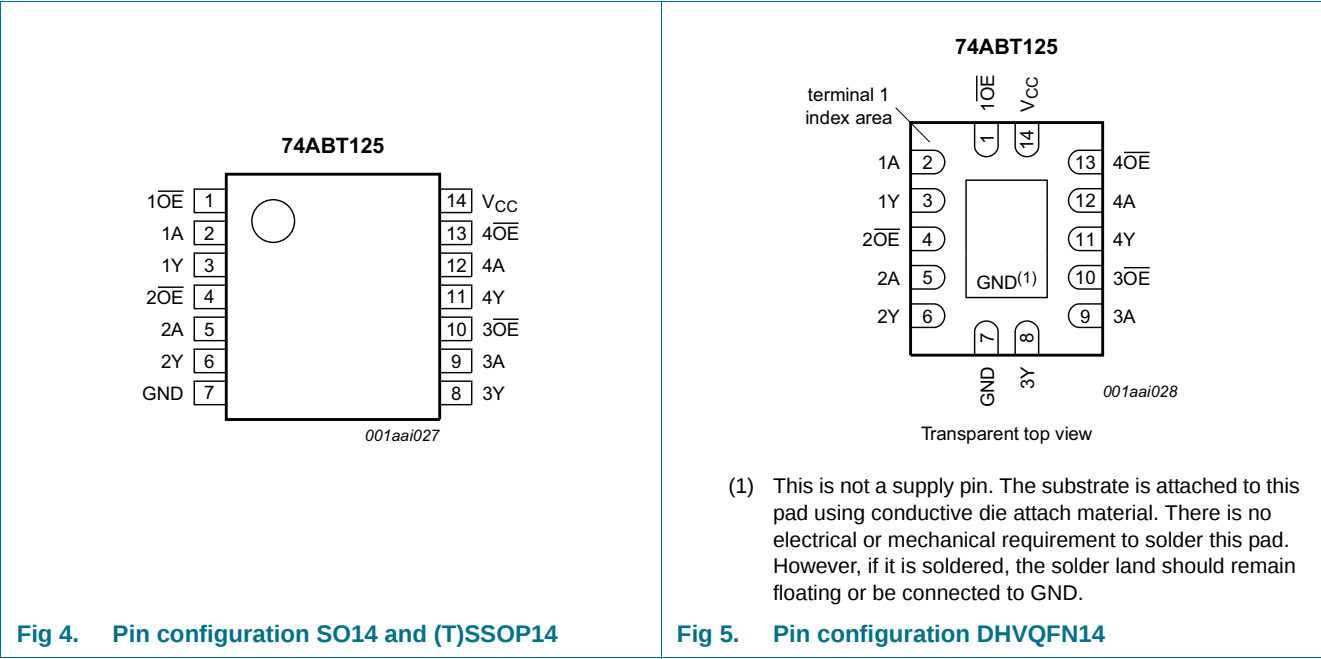


4. Functional diagram



5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
$\overline{1OE}$ to $\overline{4OE}$	1, 4, 10, 13	output enable input (active LOW)
1A to 4A	2, 5, 9, 12	data input
1Y to 4Y	3, 6, 8, 11	data output
GND	7	ground (0 V)
V _{CC}	14	supply voltage

6. Functional description

Table 3. Function selection^[1]

Inputs		Output
$\overline{nOE}$	nA	nY
L	L	L
L	H	H
H	X	Z

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

7. Limiting values

Table 4. Limiting values^[1]

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7.0	V
V _I	input voltage		-1.2	+7.0	V
V _O	output voltage	output in OFF-state or HIGH-state	-0.5	+5.5	V
I _{IK}	input clamping current	V _I < 0 V	-18	-	mA
I _{OK}	output clamping current	V _O < 0 V	-50	-	mA
I _O	output current	output in LOW-state	-	128	mA
T _j	junction temperature		-	150	°C
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +85 °C	-	500	mW

- [1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
- [2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.
- [3] SO14 packages: above 70 °C P_{tot} derate linearly with 8 mW/K
 SSOP14 and TSSOP14 packages: above 60 °C P_{tot} derate linearly with 5.5 mW/K
 DHVQFN14 packages: above 60 °C P_{tot} derate linearly with 4.5 mW/K

8. Recommended operating conditions

Table 5. Operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		4.5	5.5	V
V_I	input voltage		0	V_{CC}	V
V_{IH}	HIGH-level input voltage		2.0	-	V
V_{IL}	LOW-level input voltage		-	0.8	V
I_{OH}	HIGH-level output current		-32	-	mA
I_{OL}	LOW-level output current		-	64	mA
$\Delta t/\Delta V$	input transition rise and fall rate		-	10	ns/V
T_{amb}	ambient temperature	in free air	-40	+85	°C

9. Static characteristics

Table 6. Static characteristics

Symbol	Parameter	Conditions	25 °C			-40 °C to +85 °C		Unit
			Min	Typ	Max	Min	Max	
V_{IK}	input clamping voltage	$V_{CC} = 4.5\text{ V}$; $I_{IK} = -18\text{ mA}$	-	-0.9	-1.2	-	-1.2	V
V_{OH}	HIGH-level output voltage	$V_I = V_{IL}$ or V_{IH}						
		$V_{CC} = 4.5\text{ V}$; $I_{OH} = -3\text{ mA}$	2.5	2.9	-	2.5	-	V
		$V_{CC} = 5.0\text{ V}$; $I_{OH} = -3\text{ mA}$	3.0	3.4	-	3.0	-	V
		$V_{CC} = 4.5\text{ V}$; $I_{OH} = -32\text{ mA}$	2.0	2.4	-	2.0	-	V
V_{OL}	LOW-level output voltage	$V_{CC} = 4.5\text{ V}$; $I_{OL} = 64\text{ mA}$; $V_I = V_{IL}$ or V_{IH}	-	0.35	0.55	-	0.55	V
I_I	input leakage current	$V_{CC} = 5.5\text{ V}$; $V_I = \text{GND}$ or 5.5 V	-	± 0.01	± 1.0	-	± 1.0	μA
I_{OFF}	power-off leakage current	$V_{CC} = 0.0\text{ V}$; V_I or $V_O \leq 4.5\text{ V}$	-	± 5.0	± 100	-	± 100	μA
$I_{O(pu/pd)}$	power-up/power-down output current	$V_{CC} = 2.1\text{ V}$; $V_O = 0.5\text{ V}$; $V_I = \text{GND}$ or V_{CC} ; $\overline{OE} = \text{don't care}$ [1]	-	± 5.0	± 50	-	± 50	μA
I_{OZ}	OFF-state output current	$V_{CC} = 5.5\text{ V}$; $V_I = V_{IL}$ or V_{IH}						
		$V_O = 2.7\text{ V}$	-	1.0	50	-	50	μA
		$V_O = 0.5\text{ V}$	-	-1.0	-50	-	-50	μA
I_{CEX}	output high leakage current	HIGH-state; $V_O = 5.5\text{ V}$; $V_{CC} = 5.5\text{ V}$; $V_I = \text{GND}$ or V_{CC}	-	5.0	50	-	50	μA
I_O	output current	$V_{CC} = 5.5\text{ V}$; $V_O = 2.5\text{ V}$ [2]	-50	-100	-180	-50	-180	mA
I_{CC}	supply current	$V_{CC} = 5.5\text{ V}$; $V_I = \text{GND}$ or V_{CC}						
		outputs HIGH-state	-	65	250	-	250	μA
		outputs LOW-state	-	12	15	-	30	mA
		outputs disabled	-	65	250	-	50	μA

Table 6. Static characteristics ...continued

Symbol	Parameter	Conditions	25 °C			–40 °C to +85 °C		Unit
			Min	Typ	Max	Min	Max	
ΔI_{CC}	additional supply current	per control pin; $V_{CC} = 5.5$ V; one control input at 3.4 V, other inputs at V_{CC} or GND ^[3]						
		outputs enabled	-	0.5	1.5	-	1.5	mA
		outputs disabled	-	50	250	-	250	mA
		one enable input at 3.4 V and other inputs at V_{CC} or GND; outputs disabled	-	0.5	1.5	-	1.5	mA
C_I	input capacitance	$V_I = 0$ V or V_{CC}	-	4	-	-	-	pF
C_O	output capacitance	outputs disabled; $V_O = 0$ V or V_{CC}	-	7	-	-	-	pF

[1] This parameter is valid for any V_{CC} between 0 V and 2.1 V, with a transition time of up to 10 ms. From $V_{CC} = 2.1$ V to $V_{CC} = 5$ V ± 10 %, a transition time of up to 100 μ s is permitted.

[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[3] This is the increase in supply current for each input at 3.4 V.

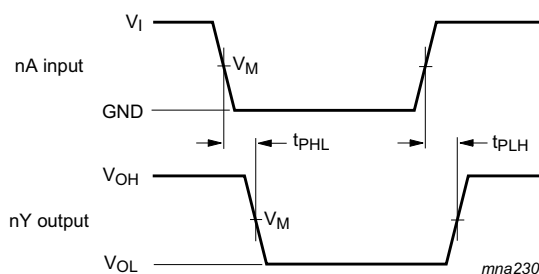
10. Dynamic characteristics

Table 7. Dynamic characteristics

$GND = 0$ V. Test circuit is shown in [Figure 8](#).

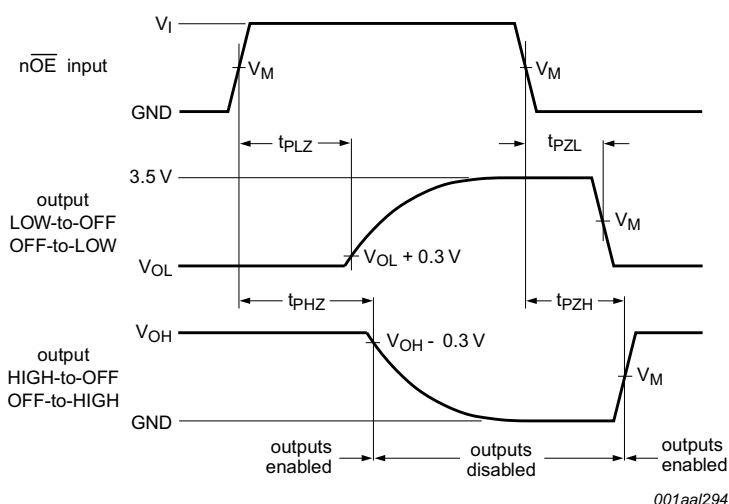
Symbol	Parameter	Conditions	25 °C; $V_{CC} = 5.0$ V			–40 °C to +85 °C; $V_{CC} = 5.0$ V ± 0.5 V		Unit
			Min	Typ	Max	Min	Max	
t_{PLH}	LOW to HIGH propagation delay	nA to nY; see Figure 6	1.0	2.8	4.1	1.0	4.6	ns
t_{PHL}	HIGH to LOW propagation delay	nA to nY; see Figure 6	1.0	3.1	4.6	1.0	4.9	ns
t_{PZH}	OFF-state to HIGH propagation delay	$\overline{nOE}$ to nY; see Figure 7	1.0	3.2	5.0	1.0	5.9	ns
t_{PZL}	OFF-state to LOW propagation delay	$\overline{nOE}$ to nY; see Figure 7	1.0	4.2	6.2	1.0	6.8	ns
t_{PHZ}	HIGH to OFF-state propagation delay	$\overline{nOE}$ to nY; see Figure 7	1.0	4.1	5.4	1.0	6.2	ns
t_{PLZ}	LOW to OFF-state propagation delay	$\overline{nOE}$ to nY; see Figure 7	1.5	2.8	5.0	1.5	5.5	ns

11. Waveforms


$$V_M = 1.5 \text{ V}$$

V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 6. Propagation delay input (nA) to output (nY)


$$V_M = 1.5 \text{ V}$$

V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 7. Enable and disable times

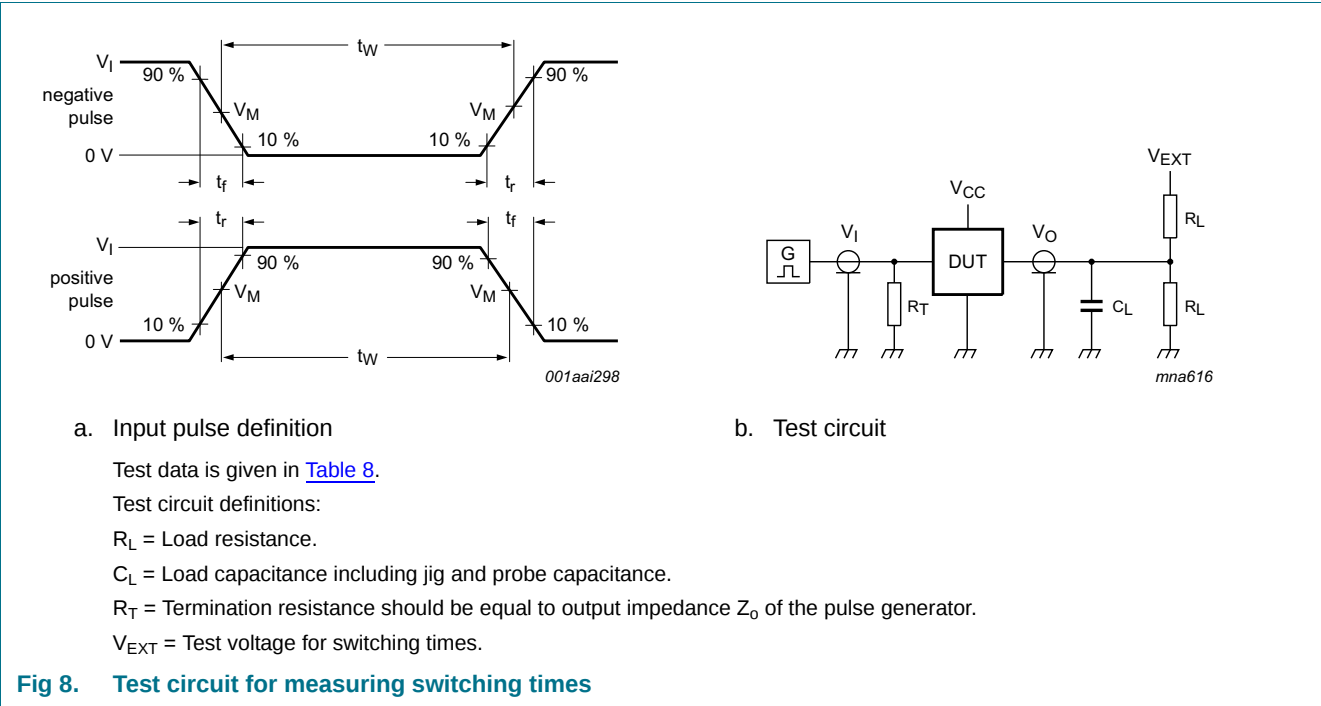


Table 8. Test data

Input				Load		V_{EXT}		
V_I	f_I	t_W	t_r, t_f	C_L	R_L	t_{PHL}, t_{PLH}	t_{PZH}, t_{PHZ}	t_{PZL}, t_{PLZ}
3.0 V	1 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	open	open	7.0 V

12. Package outline

SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1

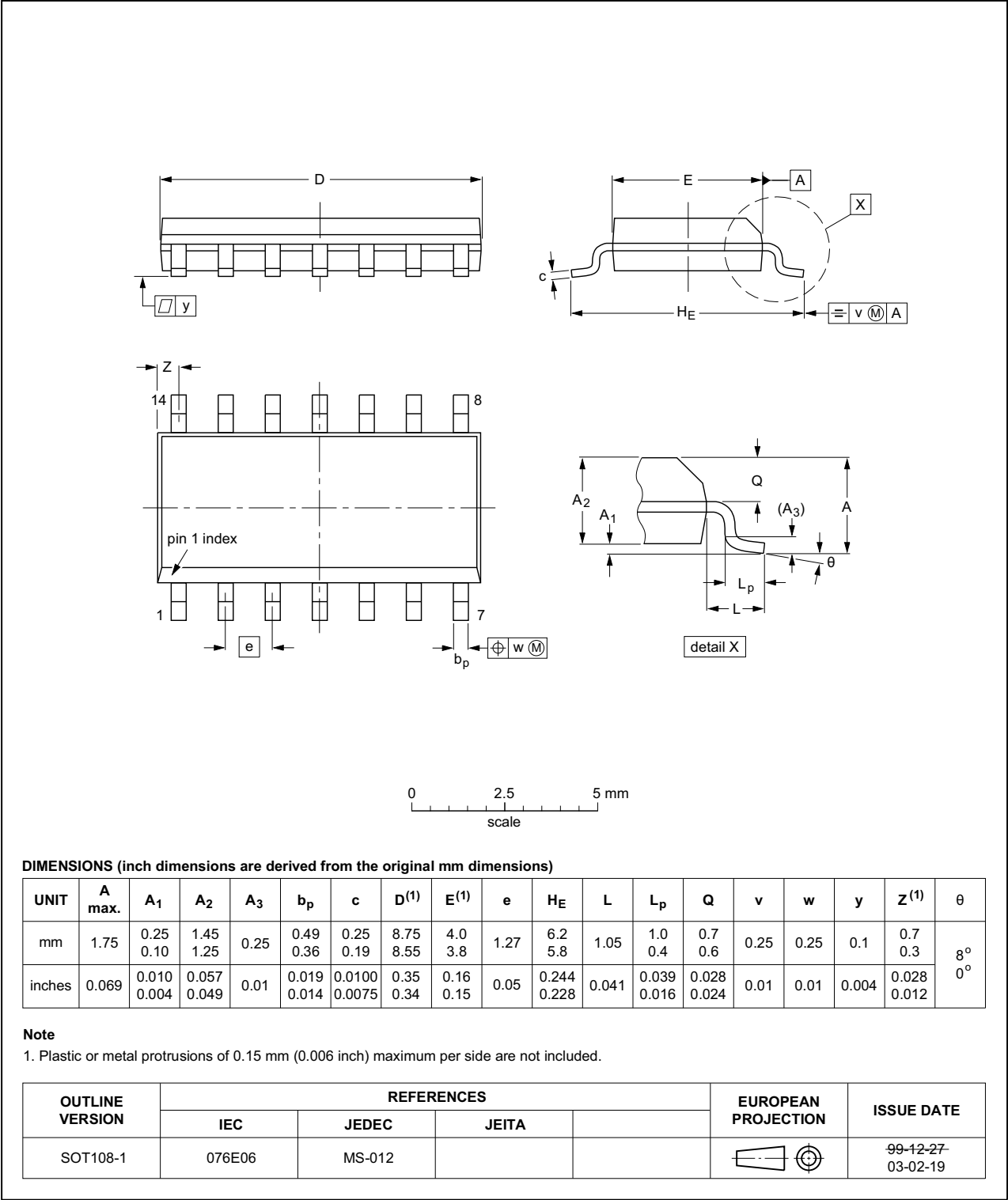


Fig 9. Package outline SOT108-1 (SO14)

SSOP14: plastic shrink small outline package; 14 leads; body width 5.3 mm

SOT337-1

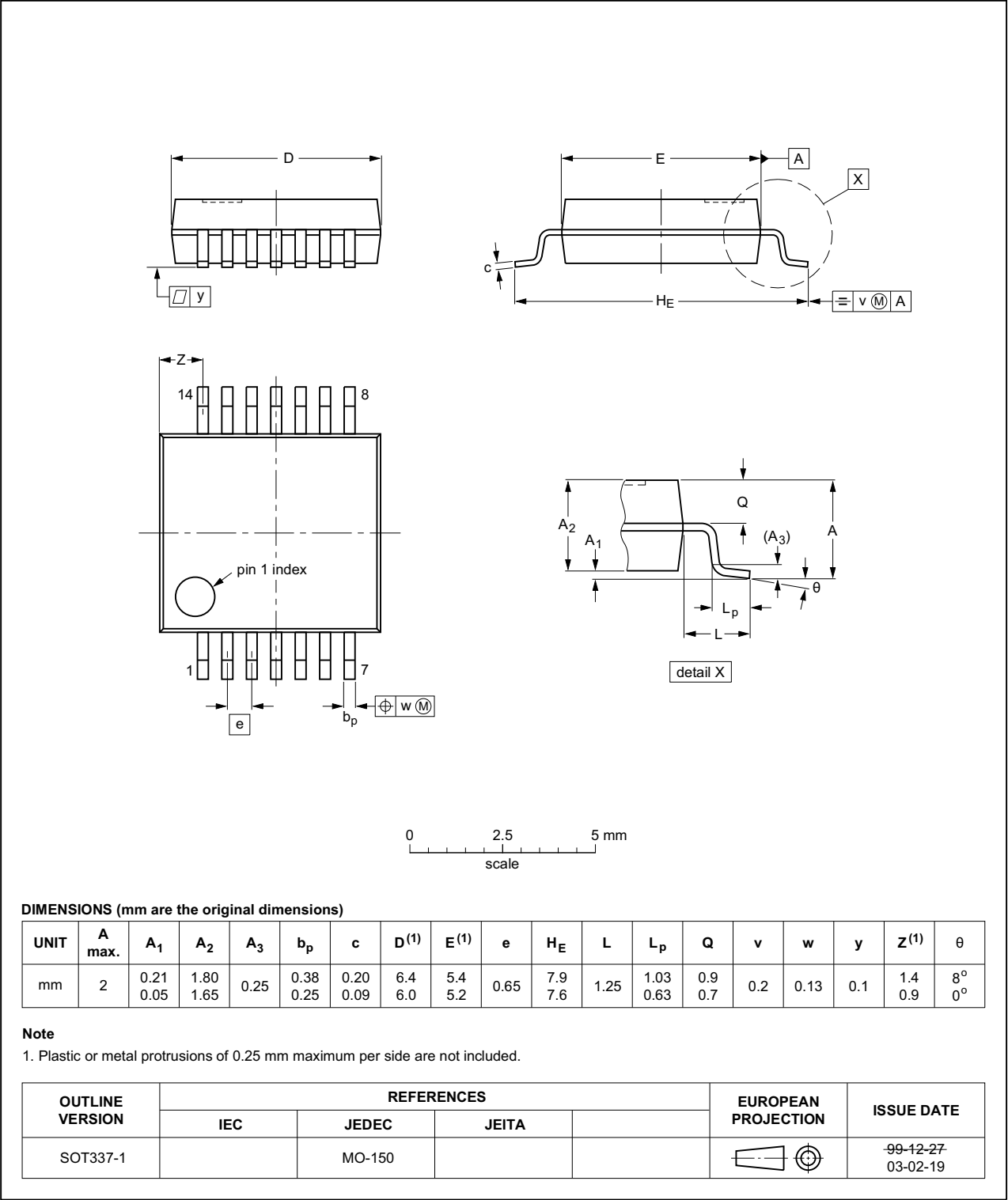


Fig 10. Package outline SOT337-1 (SSOP14)

TSSOP14: plastic thin shrink small outline package; 14 leads; body width 4.4 mm
SOT402-1

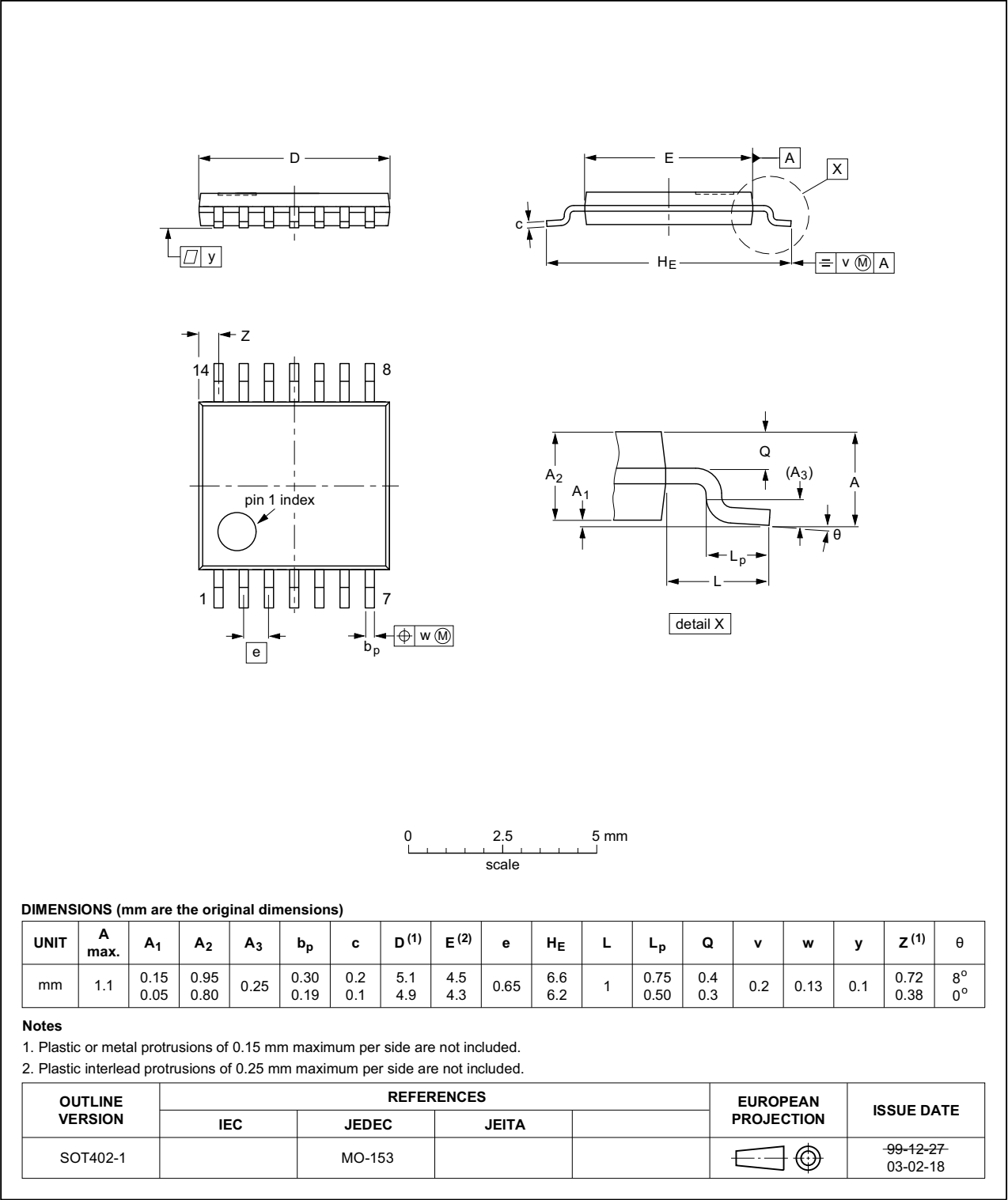


Fig 11. Package outline SOT402-1 (TSSOP14)

DHVQFN14: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads;
14 terminals; body 2.5 x 3 x 0.85 mm

SOT762-1

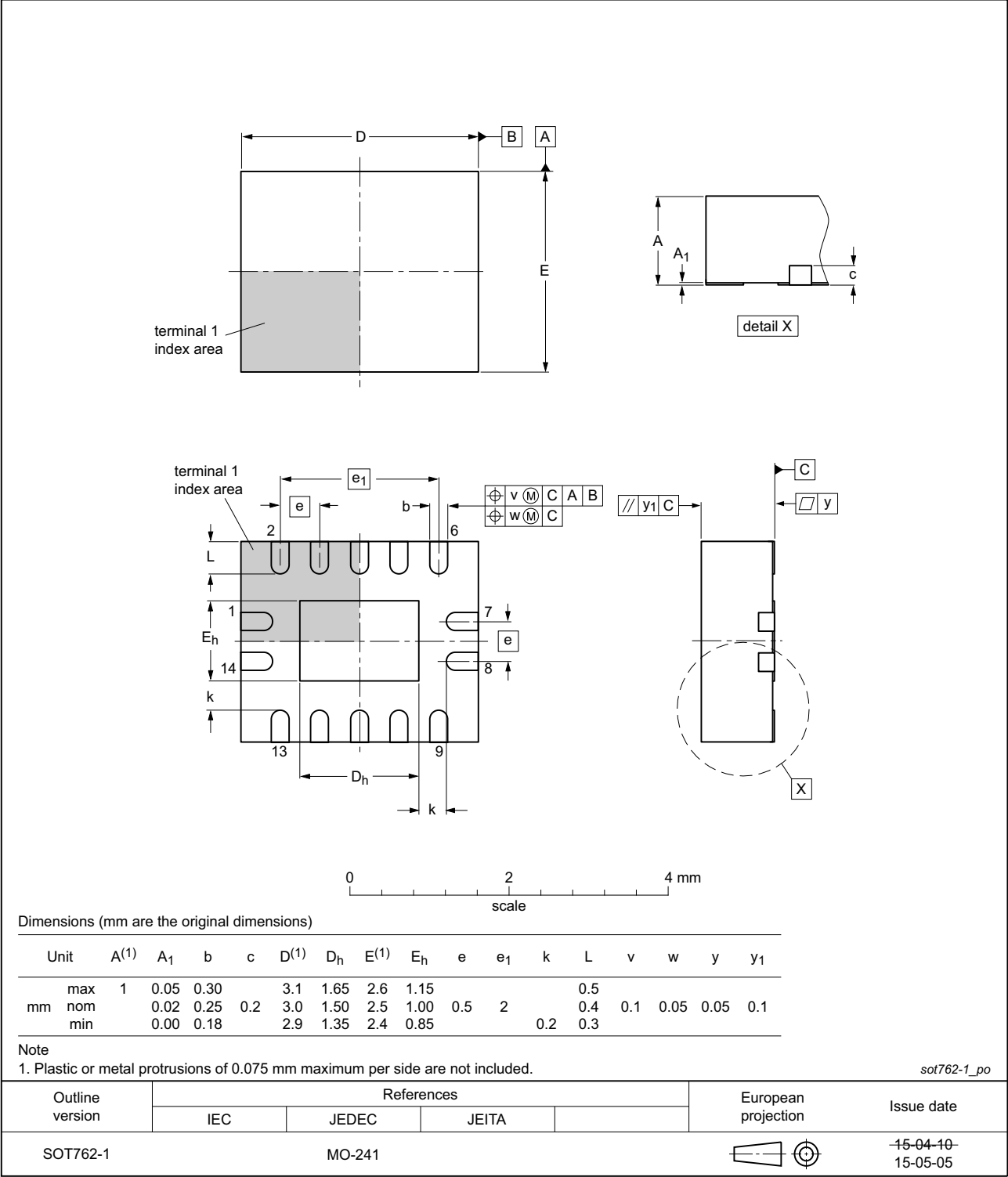


Fig 12. Package outline SOT762-1 (DHVQFN14)

13. Abbreviations

Table 9. Abbreviations

Acronym	Description
BICMOS	BipolarCMOS
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model

14. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT125 v.7	20151125	Product data sheet	-	74ABT125 v.6
Modifications:	• Type number 74ABT125N (SOT27-1) removed.			
74ABT125 v.6	20111103	Product data sheet	-	74ABT125 v.5
Modifications:	• Legal pages updated			
74ABT125 v.5	20101124	Product data sheet	-	74ABT125 v.4
74ABT125 v.4	20100427	Product data sheet	-	74ABT125 v.3
74ABT125 v.3	20080429	Product data sheet	-	74ABT125 v.2
74ABT125 v.2	19980116	Product specification	-	74ABT125 v.1
74ABT125 v.1	19960305	-	-	-

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Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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